

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10786621	REED ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Liao, Diana J	4116

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
423	592.1, 594.17, 62	10/9/2007	DJL
75	255	10/10/2007	DJL
419	19	10/10/2007	DJL
423	592.1, 594.17, 62	6/25/2008	DJL
75	255	6/25/2008	DJL
419	19	6/25/2008	DJL

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Inventor search done in eDan	10/9/2007	DJL
Databases used: EAST	10/10/2007	DJL
STIC search requested	10/11/2007	DJL
Updated EAST search	6/25/2008	DJL

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>